

Search Notes

Application/Control No.

10/624,406

Examiner

VanThu Nguyen

Applicant(s)/Patent under
Reexamination

HANNAH ET AL.

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	120 o 121 x 122 x 128 x 171 x	2/3/2005	VTN
	174 x		
	217 x		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as	above	2/4/2005	VTN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search conducted, but result lost due to computer problem	2/3/2005	VTN